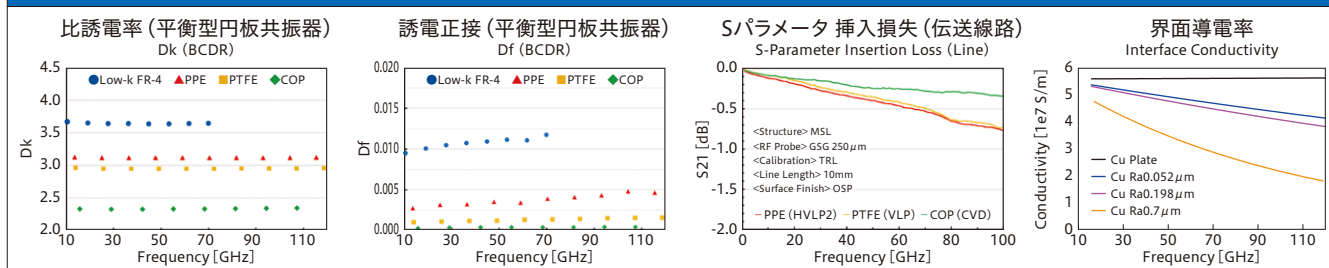


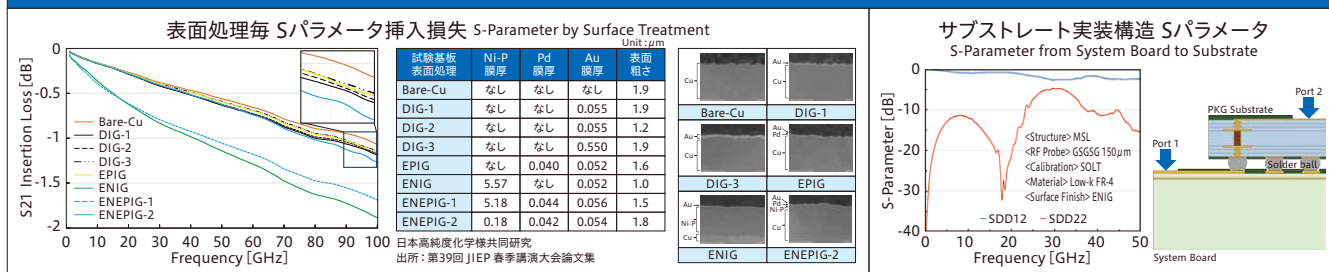
計測・評価

Measurement-Evaluation-Reliability Test

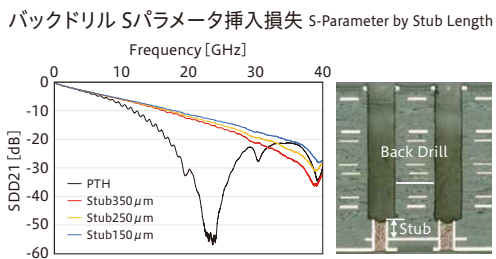
比誘電率/誘電正接/界面導電率測定 Measurement of Material Dk/Df/Interface Conductivity



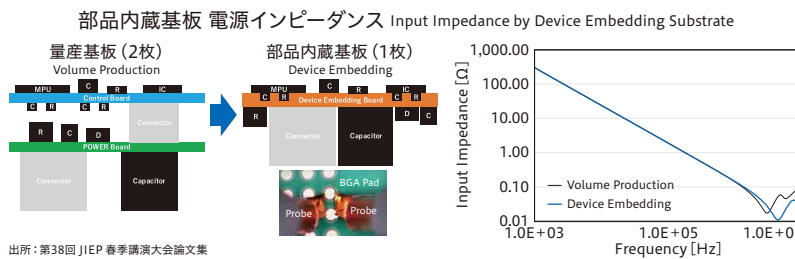
伝送線路計測 Transmission Line S-Parameter Measurement



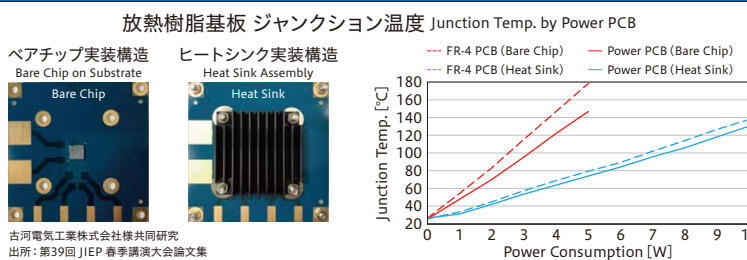
伝送線路計測 S-Parameter Measurement



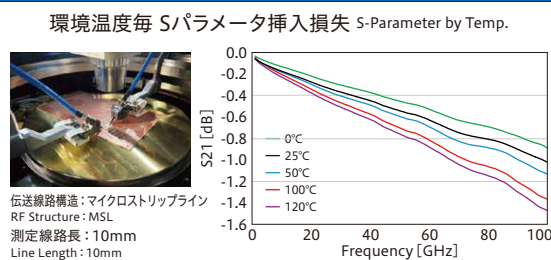
電源インピーダンス計測 Input Impedance Measurement



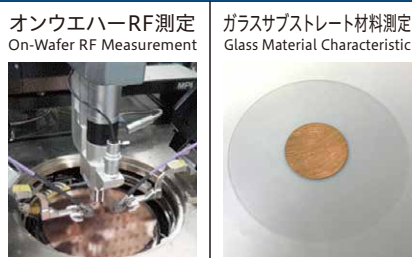
半導体チップ温度計測 IC Temperature Measurement



伝送線路計測 S-Parameter Measurement



ウエハー/ガラスサブストレート測定 Wafer/Glass Substrate Measurement



信頼性試験 Reliability Test

